

ON Semiconductor®

FDMS9410-F085

N-Channel PowerTrench® MOSFET 40 V, 50 A, 4.4 m Ω

Features

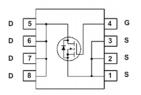
- Typical $R_{DS(on)}$ = 3.7 m Ω at V_{GS} = 10V, I_D = 50 A
- Typical $Q_{q(tot)}$ = 24 nC at V_{GS} = 10V, I_D = 50 A
- UIS Capability
- RoHS Compliant
- Qualified to AEC Q101

Applications

- Automotive Engine Control
- PowerTrain Management
- Solenoid and Motor Drivers
- Electronic Steering
- Integrated Starter/Alternator
- Distributed Power Architectures and VRM
- Primary Switch for 12V Systems







For current package drawing, please refer to the web-site at https://www.onsemi.com

MOSFET Maximum Ratings $T_J = 25$ °C unless otherwise noted.

Symbol	Parameter	Ratings	Units	
V _{DSS}	Drain-to-Source Voltage		40	V
V _{GS}	Gate-to-Source Voltage	±20	V	
I _D	Drain Current - Continuous (V _{GS} =10) (Note 1)	T _C = 25°C	50	^
	Pulsed Drain Current	T _C = 25°C	See Figure 4	Α
E _{AS}	Single Pulse Avalanche Energy	(Note 2)	39	mJ
D	Power Dissipation		75	W
P_{D}	Derate Above 25°C		0.5	W/°C
T _J , T _{STG}	Operating and Storage Temperature		-55 to + 175	°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case		2	°C/W
$R_{\theta JA}$	Maximum Thermal Resistance, Junction to Ambient	(Note 3)	50	°C/W

Notes:

- 1: Current is limited by bondwire configuration.
- 2: Starting T_J = 25°C, L = 0.1mH, I_{AS} = 28A, V_{DD} = 40V during inductor charging and V_{DD} = 0V during time in avalanche.

 3: R_{0,JA} is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2oz copper.

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS9410	FDMS9410-F085	Power56	13"	12mm	3000units

Units

Max.

Electrical Characteristics $T_J = 25$ °C unless otherwise noted.

Parameter

Off Characteristics							
B _{VDSS}	Drain-to-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		40	-	-	V
I _{DSS}	Drain-to-Source Leakage Current	V _{DS} =40V,	$T_{\rm J} = 25^{\rm o}{\rm C}$	1	-	1	μΑ
		$V_{GS} = 0V$	$T_J = 175^{\circ}C \text{ (Note 4)}$	-	-	1	mA
I_{GSS}	Gate-to-Source Leakage Current	$V_{GS} = \pm 20V$		-	-	±100	nA

Test Conditions

Min.

Тур.

On Characteristics

Symbol

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		2.0	3.2	4.0	V
R _{DS(on)}	Drain to Source On Resistance	I _D = 50A,	$T_{\rm J} = 25^{\rm o}{\rm C}$	-	3.7	4.4	mΩ
		V _{GS} = 10V	$T_J = 175^{\circ}C \text{ (Note 4)}$	-	6.6	7.9	mΩ

Dynamic Characteristics

C _{iss}	Input Capacitance	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1MHz		-	1790	-	pF
C _{oss}	Output Capacitance			-	620	-	pF
C _{rss}	Reverse Transfer Capacitance			-	32	-	pF
R_g	Gate Resistance	f = 1MHz		-	2.0	-	Ω
$Q_{g(ToT)}$	Total Gate Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DD} = 32V$ $I_{D} = 50A$		-	24	36	nC
$Q_{g(th)}$	Threshold Gate Charge			-	3.3	-	nC
Q_{gs}	Gate-to-Source Gate Charge		_	-	9.1	-	nC
Q_{gd}	Gate-to-Drain "Miller" Charge			-	4.5	-	nC

Switching Characteristics

t _{on}	Turn-On Time		-	-	27	ns
t _{d(on)}	Turn-On Delay		-	12.1	-	ns
t _r	Rise Time	V _{DD} = 20V, I _D = 50A,	-	5.9	-	ns
t _{d(off)}	Turn-Off Delay	V_{GS} = 10V, R_{GEN} = 6Ω	-	18.8	-	ns
t _f	Fall Time		-	5.0	-	ns
t _{off}	Turn-Off Time		-	-	31	ns

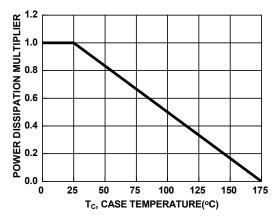
Drain-Source Diode Characteristics

V_{SD}	Source-to-Drain Dioge Voltage	I _{SD} =50A, V _{GS} = 0V	-	-	1.25	V
		$I_{SD} = 25A, V_{GS} = 0V$	-	-	1.2	٧
t _{rr}	Reverse-Recovery Time	I _F = 50A, dI _{SD} /dt = 100A/μs	-	45.5	59	ns
Q _{rr}	Reverse-Recovery Charge	V _{DD} = 32V	-	33.2	43	nC

Note:

^{4:} The maximum value is specified by design at T_J = 175°C. Product is not tested to this condition in production.

Typical Characteristics



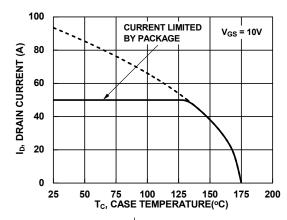


Figure 1. Normalized Power Dissipation vs. Case Temperature

Figure 2. Maximum Continuous Drain Current vs.

Case Temperature

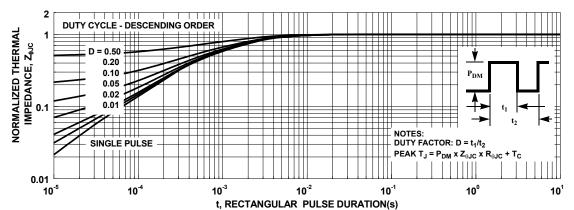


Figure 3. Normalized Maximum Transient Thermal Impedance

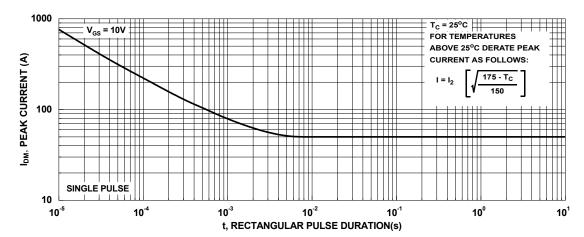


Figure 4. Peak Current Capability

Typical Characteristics

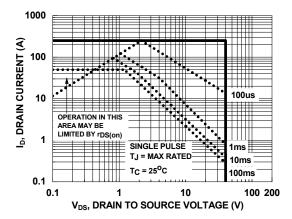
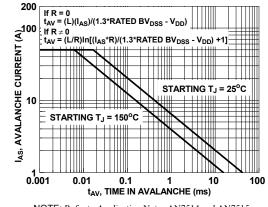


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching

Capability

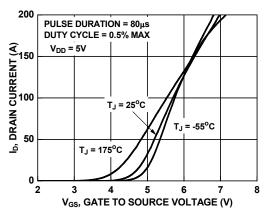


Figure 7. Transfer Characteristics

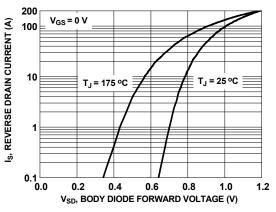


Figure 8. Forward Diode Characteristics

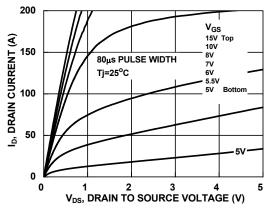


Figure 9. Saturation Characteristics

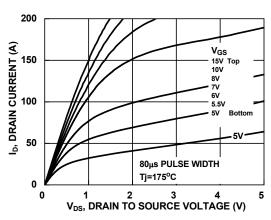


Figure 10. Saturation Characteristics

Typical Characteristics

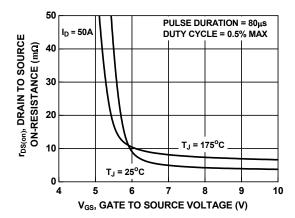


Figure 11. R_{DSON} vs. Gate Voltage

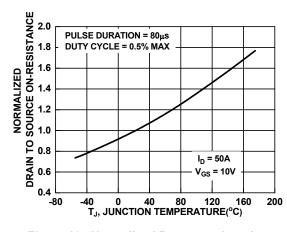


Figure 12. Normalized R_{DSON} vs. Junction Temperature

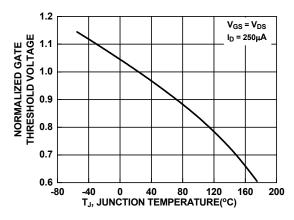


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

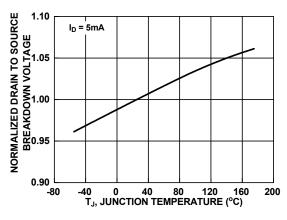


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

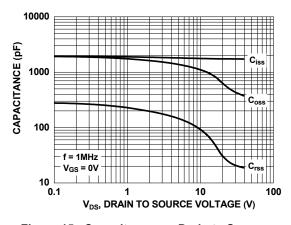


Figure 15. Capacitance vs. Drain to Source Voltage

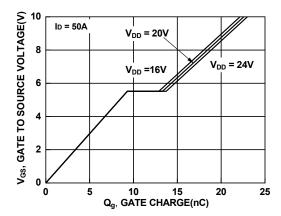


Figure 16. Gate Charge vs. Gate to Source Voltage

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hol

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Phone: 421 33 790 2910

Japan Customer Focus Center
Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative